

# Plant Optimization - Taking Control of Manufacturing Operations

written by Lauri Moon | April 27, 2017

## Description

**Smart Manufacturing, IoT, Industry 4.0** — these are all ways for companies to beat the competition. However, you can't achieve any of these unless you have a means of properly optimizing your plants.

Relying only on Top Floor to Shop Floor visibility is no longer an option for 21st century manufacturers. Maximizing production capabilities and ensuring uptime is critical, requiring immediate status as an input to production schedules. **Accurate useable production information becomes your foundation** for continued investment in the overall Digital Enterprise.

Join us on May 17 for a discussion on the benefits of Plant Optimization and discover **how you can take greater command of your manufacturing operations**, including:

- Ensuring enterprise-wide optimization and operational excellence
- Getting the most performance from your capital investments
- Enhancing manufacturing intelligence and Electronic Manufacturing Intelligence (EMI)
- Real-time and KPI visibility into process environments
- Identifying your production pain points
- Maximizing production efficiency to deliver products on time

Come with your own operations challenges and leave with a roadmap to a more flexible and efficient operation.

## Presenter



## **Chris Weber, Portfolio Development Executive, Siemens PLM Software**

Chris Weber primarily focused on the development of manufacturing solutions within the Digital Enterprise. In the last 31 years, he has spent the majority of his career focused on manufacturing solutions in multiple industries such as Automotive, A&D, and Machinery. From his early years of directly supporting the plant floor, to managing Industrial and Manufacturing Engineering groups, to providing consulting services, Weber has been able to merge his manufacturing process knowledge with his digital manufacturing knowledge to help develop business solutions for Siemens customers. He holds a patent for a lifecycle digital maturity assessment model which he co-developed.

**Register**